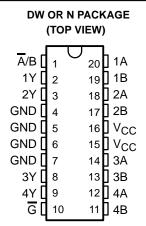
74ACT11258 **QUADRUPLE 2-LINE TO 1-LINE DATA SELECTOR/MULTIPLEXER** WITH 3-STATE OUTPUTS

SCAS056A - D3278, JANUARY 1989 - REVISED APRIL 1993

- Inputs Are TTL-Voltage Compatible
- 3-State Outputs Interface Directly With **System Bus**
- Flow-Through Architecture to Optimize **PCB Layout**
- Center-Pin V_{CC} and GND Configurations **Minimize High-Speed Switching Noise**
- EPIC™ (Enhanced-Performance Implanted CMOS) 1-µm Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Provides Bus Interface from Multiple **Sources in High-Performance Systems**
- Package Options Include Plastic **Small-Outline Packages and Standard** Plastic 300-mil DIPs



description

The 74ACT11258 is designed to multiplex signals from 4-bit data sources to 4-output data lines in bus-organized systems. The 3-state outputs will not load the data lines when the output control pin (\overline{G}) is at a high logic level.

The 74ACT11258 is characterized for operation from – 40°C to 85°C.

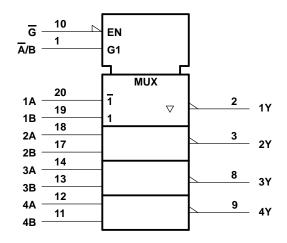
FUNCTION TABLE

OUTPUT CONTROL	SELECT	DA	TA	OUTPUT Y
G	A/B	Α	В	-
Н	Х	Х	Х	Z
L	L	L	Χ	Н
L	L	Н	Χ	L
L	Н	Х	L	Н
L	Н	Х	Н	L

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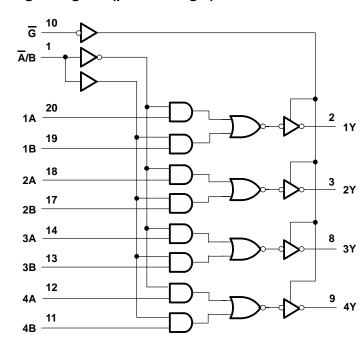


logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}	– 0.5 V to 7 V
Input voltage range, V _I (see Note 1)	– 0.5 V to V_{CC} + 0.5 V
Output voltage range, VO (see Note 1)	– 0.5 V to V _{CC} + 0.5 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	± 20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})	± 50 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	$ \pm 50 \text{ mA}$
Continuous current through V _{CC} or GND	± 100 mA
Storage temperature range	– 65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	V
VIH	High-level input voltage	2		V
V_{IL}	Low-level input voltage		0.8	V
VI	Input voltage	0	VCC	V
VO	Output voltage	0	VCC	V
ЮН	High-level output current		-24	mA
lOL	Low-level output current		24	mA
Δt/Δν	Input transition rise or fall rate	0	10	ns/V
TA	Operating free-air temperature	- 40	85	°C



NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	vcc	T _A = 25°C		MIN	MAX	UNIT	
PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	IVIIIV	IVIAA	UNIT
	I _{OH} = - 50 μA		4.4			4.4		
			5.4			5.4		
Vон	Jour = 24 mA	4.5 V	3.94			3.8		V
	I _{OH} = – 24 mA		4.94			4.8		
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V				3.85		
	I _{OL} = 50 μA				0.1		0.1	
					0.1		0.1	
V _{OL}	lo 24 mA	4.5 V			0.36		0.44	V
	I _{OL} = 24 mA				0.36		0.44	
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V					1.65	
loz	$V_O = V_{CC}$ or GND	5.5 V			± 0.5		± 5	μΑ
IĮ	$V_I = V_{CC}$ or GND	5.5 V			± 0.1		± 1	μΑ
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		80	μΑ
Δl _{CC} ‡	One input at 3.4 V, Other inputs at V _{CC} or GND	5.5 V			0.9		1	mA
Ci	$V_I = V_{CC}$ or GND	5 V		3.5				pF
Co	$V_O = V_{CC}$ or GND	5 V		8	•		·	pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	ТО	T _A = 25°C			MIN	MAX	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	IVIIIN	IVIAA	UNII
t _{PLH}	A or B	A or B Any Y	1.5	5.4	7.7	1.5	8.5	
^t PHL	AUB		1.5	5.7	7.7	1.5	8.7	ns
^t PLH	Ā/B	Any Y	1.5	5.7	8	1.5	8.8	ns
^t PHL	A/B	Ally 1	1.5	6.7	9.4	1.5	10.4	110
^t PZH	IG	Any Y	1.5	5.7	8.1	1.5	8.8	20
^t PZL	G	Ally 1	1.5	6.4	8.8	1.5	9.8	ns
^t PHZ	G	Any Y	1.5	6.1	7.5	1.5	7.7	ns
^t PLZ	9		1.5	6.3	8.3	1.5	9	115

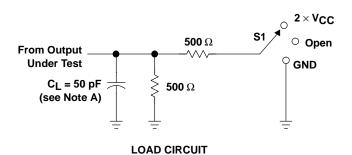
operating characteristics , V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS	TYP	UNIT	
C. Dower discination conscitones	Outputs enabled	C _I = 50 pF, f = 1 MHz	35	рF	
Cbq	Power dissipation capacitance	Outputs disabled	$C_L = 50 \text{ pF}, \qquad f = 1 \text{ MHz}$	15	pr

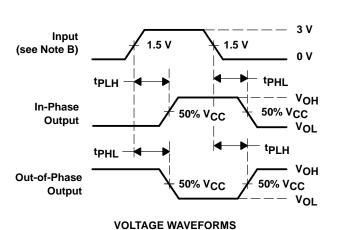
[‡] This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V to V_{CC}.

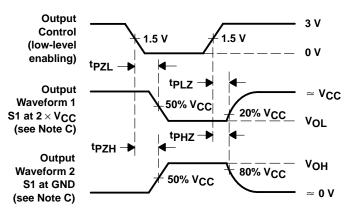
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PARAMETER MEASUREMENT INFORMATION



TEST	S1
tPLH/tPHL	Open
tPLZ/tPZL	2×V _{CC}
tPHZ/tPZH	GND





VOLTAGE WAVEFORMS

NOTES: A. C_I includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \ \Omega$, $t_f = 3 \ ns$, $t_f = 3 \ ns$.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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